

# **EMC Test Report**

Report No.: AGC05443240513ER01

**PRODUCT DESIGNATION**: Magnetic Wireless charger

**BRAND NAME** : N/A

MODEL NAME : MO2389

**APPLICANT**: MID OCEAN BRANDS B.V

**DATE OF ISSUE** : Jun. 07, 2024

**STANDARD(S)** : ETSI EN 301 489-1 V2.2.3 (2019-11)

ETSI EN 301 489-3 V2.3.2 (2023-01)

**REPORT VERSION**: V1.0





Page 2 of 46

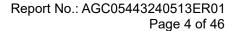
#### REPORT REVISE RECORD

Report Version	Revise Time	Issued Date	Valid Version	Notes
V1.0	/	Jun. 07, 2024	Valid	Initial Release



#### **TABLE OF CONTENTS**

1. TEST REPORT CERTIFICATION	5
2. GENERAL INFORMATION	6
2.1. DESCRIPTION OF EUT	6
2.2. OBJECTIVE	6
2.3. TEST STANDARDS AND RESULTS	6
2.4. TEST ITEMS AND THE RESULTS	7
2.5. ENVIRONMENTAL CONDITIONS	7
3. TEST MODE DESCRIPTION	8
4. MEASUREMENT UNCERTAINTY	9
5. SUPPORT EQUIPMENT	10
6. IDENTIFICATION OF THE RESPONSIBLE TESTING LOCATION	11
7. RADIATED DISTURBANCE MEASUREMENT	14
7.1. LIMITS OF RADIATED DISTURBANCES	14
7.2. TEST PROCEDURE	14
7.3. BLOCK DIAGRAM OF TEST SETUP	15
7.4 TEST RESULT	16
8. MAINS TERMINAL DISTURBANCE VOLTAGE MEASUREMENT	18
8.1. LIMITS OF MAINS TERMINAL DISTURBANCE VOLTAGE	18
8.2. TEST PROCEDURE	18
8.3. TEST SETUP	19
8.4. TEST RESULT	20
9. HARMONIC CURRENT MEASUREMENT	22
9.1. LIMITS OF HARMONIC CURRENT	22
9.2. TEST PROCEDURE	22
9.3. TEST SETUP	23
9.4. TEST RESULT	23
10. VOLTAGE FLUCTUATIONS AND FLICK MEASUREMENT	24
10.1. LIMITS OF VOLTAGE FLUCTUATIONS AND FLICK	24
10.2. TEST PROCEDURE	24
10.3. TEST SETUP	24
10.4. TEST RESULT	24
11. IMMUNITY TEST	25
11.1. DESCRIPTION OF PERFORMANCE CRITERIA	25
11.2. GENERAL PERFORMANCE CRITERIA	25
12. ELECTROSTATIC DISCHARGE IMMUNITY TEST	27
12.1. TEST SPECIFICATION	27
12.2. TEST PROCEDURE	27
12.3. TEST SETUP	28
12.4 TEST RESULT	30





12.5. PERFORMANCE	30
13. RADIATED, RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST	31
13.1. TEST SPECIFICATION	31
13.2. TEST PROCEDURE	31
13.3. TEST SETUP	32
13.4. TEST RESULT	33
13.5. PERFORMANCE	33
14. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST	34
14.1. TEST SPECIFICATION	34
14.2. TEST PROCEDURE	34
14.3. TEST SETUP	34
14.4. TEST RESULT	35
14.5. PERFORMANCE	35
15. SURGE IMMUNITY TEST	36
15.1. TEST SPECIFICATION	36
15.2. TEST PROCEDURE	36
15.3. TEST SETUP	36
15.4. TEST RESULT	37
15.5. PERFORMANCE	37
16. IMMUNITY TO CONDUCTED DISTURBANCES INDUCED BY RF FIELDS	38
16.1. TEST SPECIFICATION	38
16.2. TEST PROCEDURE	38
16.3. TEST SETUP	38
16.4. TEST RESULT	39
16.5. PERFORMANCE	39
17. VOLTAGE DIPS AND SHORT INTERRUPTIONS IMMUNITY TEST	40
17.1. TEST SPECIFICATION	40
17.2. TEST PROCEDURE	40
17.3. TEST SETUP	40
17.4. TEST RESULT	41
17.5. PERFORMANCE	41
APPENDIX A: PHOTOGRAPHS OF TEST SETUP	42
APPENDIX B. PHOTOGRAPHS OF THE FUT	46



Page 5 of 46

#### 1. TEST REPORT CERTIFICATION

1. ILOI KEI OKI OLKI	ITOATION	
Applicant	MID OCEAN BRANDS B.V	
Address	Unit 201 2/F,.Laford Centre, 838 Lai Chi Kok Road, Cheung Sha Wan, Kowloon, Hongkong	
MID OCEAN BRANDS B.V		
Address Unit 201 2/F,.Laford Centre, 838 Lai Chi Kok Road, Cheung Sha Wan, I Hongkong		
Factory	MID OCEAN BRANDS B.V	
Address	Unit 201 2/F,.Laford Centre, 838 Lai Chi Kok Road, Cheung Sha Wan, Kowloon, Hongkong	
Product Designation	Magnetic Wireless charger	
Brand Name	N/A	
Test Model	MO2389	
Series Model(s)	N/A	
Difference Description	N/A	
Date of receipt of test item	May 14, 2024	
Date of test	May 14, 2024 to Jun. 06, 2024	
Deviation	None	
Condition of Test Sample	Normal	
Test Result	Pass	
Report Template	AGCRT-EC-EMC	

Note: The test results of this report relate only to the tested sample identified in this report.

xCili Prepared By Cici Li Jun. 07, 2024 (Project Engineer) Reviewed By Calvin Liu Jun. 07, 2024 (Reviewer) Approved By Max Zhang Jun. 07, 2024 Authorized Officer



Page 6 of 46

#### 2. GENERAL INFORMATION

#### 2.1. DESCRIPTION OF EUT

Details of technical specification refer to the description in follows:

Operating Frequency	100KHz-205KHz		
Modulation	ASK		
Hardware Version	V1.0		
Software Version	V1.0		
Antenna Type	Coil Antenna		
EUT Input& Output Rating	Input: DC 5V/2A, 9V/1.67V, 12V/1.5A Output: DC 5V/1A, 9V/1.1A, 9V/1.67A		
Wireless Charging Output Power	5W/10W/15W (Max 15W)		

#### 2.2. OBJECTIVE

Perform Electro Magnetic Interference (EMI) and Electro Magnetic Susceptibility (EMS) tests for CE Marking.

#### 2.3. TEST STANDARDS AND RESULTS

The EUT has been tested according to ETSI EN 301 489-1 V2.2.3 (2019-11) and ETSI EN 301 489-3 V2.3.2 (2023-01)

	ElectroMagnetic Compatibility (EMC) standard for radio equipment and services; Part		
ETSI EN 301 489-1	1: Common technical requirements; Harmonised Standard for ElectroMagnetic		
	Compatibility.		
ETSI EN 301 489-3	Electro Magnetic Compatibility (EMC) standard for radio equipment and services;		
	Part 3: Specific conditions for Short-Range Devices (SRD) operating on frequencies		
	between 9 kHz and 246 GHz; Harmonised Standard covering the essential		
	requirements of article 3.1(b) of Directive 2014/53/EU		



Page 7 of 46

#### 2.4. TEST ITEMS AND THE RESULTS

No.	Basic Standard Test Type				
EMIS	EMISSION (EN 301 489-1 §7.1)				
1	EN 55032	Radiated emission	PASS		
3	EN 55032	Conducted emission, AC ports	PASS		
4	EN 55032	Conducted emission, Telecom ports	N/A		
5	EN 61000-3-2	Harmonic current emissions	PASS		
6	EN 61000-3-3	Voltage fluctuations & flicker	PASS		
IMM	IMMUNITY (EN 301 489-1 §7.2)				
7	EN 61000-4-2	Electrostatic discharge immunity	PASS		
8	EN 61000-4-3	Radiated RF electromagnetic field immunity	PASS		
9	EN 61000-4-4	Electrical fast transient/burst immunity	PASS		
10	ISO 7637-1, -2	Transients and surges, DC ports	N/A		
11	EN 61000-4-5	Surge immunity, AC ports, Telecom ports	PASS		
12	EN 61000-4-6	Immunity to conducted disturbances induced by RF fields	PASS		
13	EN 61000-4-11	Voltage dips and short interruptions immunity	PASS		

Note: 1. N/A- Not Applicable.

2. The latest versions of basic standards are applied.

## 2.5. ENVIRONMENTAL CONDITIONS

During the measurement the environmental conditions were within the listed ranges:

Temperature: 15-35°CRelative humidity: 30-60%

- Atmospheric pressure: 86-106kPa



Page 8 of 46

## 3. TEST MODE DESCRIPTION

TEST MODE DESCRIPTION			
NO.	EMI TEST MODE DESCRIPTION	WORST	
1	Full Load mode		
2	Half Load mode		
3	Null Load mode		
NO.	EMS TEST MODE DESCRIPTION	WORST	
1	Full Load mode		
2	Half Load mode		
3	Null Load mode		

## I/O Port Information (⊠ Applicable ☐ Not Applicable)

I/O Port of EUT					
I/O Port Type Number Cable Description Tested With					
USB Type-C	1	0.9m unshielded	1		



Page 9 of 46

#### 4. MEASUREMENT UNCERTAINTY

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in measurement" (GUM) published by CISPR and ANSI.

- Uncertainty of Radiated Emission, Uc = ±2.9dB
- Uncertainty of Radiated Emission below 1GHz, Uc = ±3.9 dB
- Uncertainty of Radiated Emission above 1GHz, Uc = ±4.9 dB



Page 10 of 46

#### 5. SUPPORT EQUIPMENT

Device Type	Manufacturer	Model	Serial No	Data Cable	Mains cable
Wireless Charging Load	Huawei				

Note: 1. "-- "means no any support device during testing.



Report No.: AGC05443240513ER01 Page 11 of 46

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Site	Attestation of Global Compliance (Shenzhen) Co., Ltd
Location	1-2/F, Building 19, Junfeng Industrial Park, Chongqing Road, Heping Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China

#### TEST EQUIPMENT OF CONDUCTED EMISSION TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
TEST RECEIVER	R&S	ESPI	101206	Jun. 03, 2023	Jun. 02, 2024
TEST RECEIVER	R&S	ESPI	101206	May 28, 2024	May 27, 2025
LISN	R&S	ESH2-Z5	100086	Jun. 03, 2023	Jun. 02, 2024
LISN	R&S	ESH2-Z5	100086	May 28, 2024	May 27, 2025
Test Software	FARA	Ver. AGC-CON03A 1	N/A	N/A	N/A

#### **TEST EQUIPMENT OF RADIATED EMISSION TEST**

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due	
Test Receiver	R&S	ESCI	10096	Feb. 01, 2024	Jan. 31, 2025	
ANTENNA	SCHWARZBECK	VULB9168	VULB9168-49 4	Jan. 05, 2023	023 Jan. 04, 2025	
Double-Ridged Waveguide Horn	ETS LINDGREN	3117	00034609	Mar. 31, 2024	Mar. 30, 2025	
EXA Signal Analyzer	Aglient	N9010A	MY53470504	Jun. 01, 2023	May 31, 2024	
EXA Signal Analyzer	Aglient	N9010A	MY53470504	May 28, 2024	May 27, 2025	
Test Software	FARA	FARA Ver.RA-03A		N/A	N/A	
Test Software	Tonscend	Ver.2.5	N/A	N/A	N/A	

#### TEST EQUIPMENT OF POWER HARMONICS / VOLTAGE FLUCTUATION / FLICKER TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due	
Signal Conditioning Unit	Schaffner CCN1000-1		72431	Jun. 08, 2023	Jun. 07, 2024	
AC Source	Schaffner	NSG1007	56825	Jun. 02, 2023	Jun. 01, 2024	
AC Source	Schaffner	NSG1007	56825	May 24, 2024	May 23, 2025	
Test software	TC	4.29.0	1	N/A	N/A	



Page 12 of 46

#### **TEST EQUIPMENT OF ESD TEST**

Equipment Manufacturer		Model S/N		Cal. Date	Cal. Due	
ESD Simulator	Schaffner	NSG 438	782	Nov. 13, 2023	Nov. 12, 2024	

#### **EST EQUIPMENT OF SURGE/EFT/DIPS TEST**

Equipment	Manufacturer	Model	Model S/N		Cal. Due
EFT Surge Generator	Schaffner	Modula 6150	34437	Jun. 08, 2022	Jun. 07, 2024
Test software	TC	2.31	/	N/A	N/A

#### TEST EQUIPMENT OF RS IMMUNITY TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due		
Signal Generator	R&S	N5182A	MY50140530	Jun. 01, 2023	May 31, 2024		
Signal Generator	R&S	N5182A	MY50140530	May 23, 2024	May 22, 2025		
POWER SENSOR	R&S	U2021XA	MY54110007	Aug. 12,2022	Aug. 11,2024		
POWER METER	R&S	NRVD	8323781027	Mar. 24 2023	Mar. 23 2025		
POWER AMPLIFIER	KALMUS	7100LC	04-02/17-06- 001	N/A	N/A		
RF AMPLIFIER	Milmega	AS0104-55_55	1004793	N/A	N/A		
Bi-log antenna	ETS	3142C	920250	Jun. 08, 2022	Jun. 07, 2024		
Double-Ridged Waveguide Horn	ETS LINDGREN	3117	00034609	Mar. 31 2024	Mar. 30 2025		
Broadband high gain horn antenna	SCHWARZBECK	BBHA 9120 J	00073	N/A	N/A		
Test software	Tnscend	JS35-RS	2.0.1.8	N/A	N/A		



Page 13 of 46

#### **EST EQUIPMENT OF CS IMMUNITY TEST**

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Power Amplifier	AR	75A250	18464	N/A	N/A
CDN	ZHINAN	ZN3751	15004	Aug. 03, 2022	Aug. 02, 2024
6dB attenuator	enuator ZHINAN E-002		N/A	Aug. 03, 2022	Aug. 02, 2024
Electromagnetic Injection Clamp	Luthi	Luthi EM101 357		Aug. 12, 2022	Aug. 11, 2024
Power Sensor	R&S	URV5-Z4	100124	Mar. 24, 2023	Mar. 23, 2025
POWER METER	R&S	NRVD	8323781027	Mar. 24 2023	Mar. 23 2025
SIGNAL GENERATOR	R&S	E4421B	MY43351603	Feb. 01, 2024	Jan. 31, 2025
Test software	Tnscend	JS35-CS	2.0.1.7	N/A	N/A



Page 14 of 46

#### 7. RADIATED DISTURBANCE MEASUREMENT

#### 7.1. LIMITS OF RADIATED DISTURBANCES

Limits for radiated disturbance 30M to1 GHz at a measurement distance of 3 m

Frequency range (MHz)	Quasi peak limits(dBuV/m), for Class B ITE, at 3m measurement distance
30-230	40
230-1000	47

#### Limits for radiated disturbance above 1 GHz at a measurement distance of 3 m

Eroguanov ranga (MU=)	Limits (dBuV/m), Class B ITE			
Frequency range (MHz)	Peak	Average		
1000-3000	70	50		
3000-6000	74	54		

**Note:** 1. The lower limit shall apply at the transition frequency.

2. Additional provisions may be required for cases where interference occurs.

#### 7.2. TEST PROCEDURE

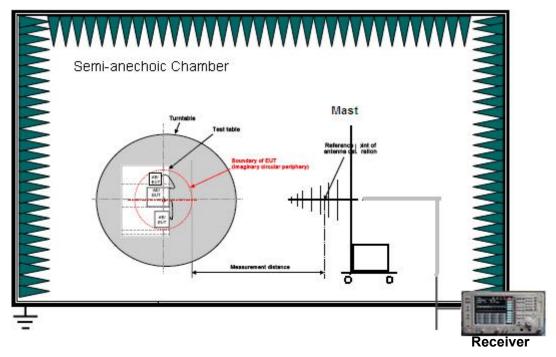
- (1). The EUT was placed on the top of an insulating table 0.8 meters above the ground at a semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- (2). The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- (3). The antenna is a broadband antenna, and its height is varied from 1 to 4 meter above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- (4). For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to the heights from 1 to 4 meters and the ratable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- (5). The test-receiver system was set to Peak Detector Function and Specified Bandwidth with Maximum Hold Mode. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emission that did not have 10dB margin would be retested one by one using the quasi-peak method.



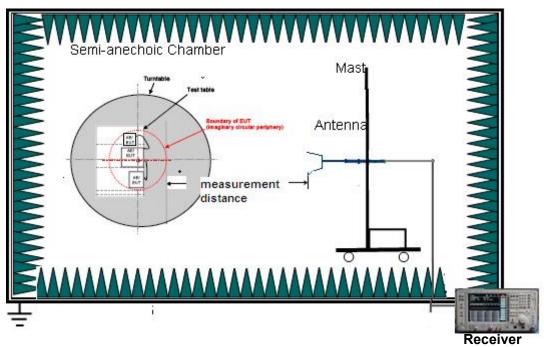
#### 7.3. BLOCK DIAGRAM OF TEST SETUP

System Diagram of Connections between EUT and Simulators

#### Radiated Disturbance below 1 GHz



#### Radiated Disturbance above 1 GHz



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

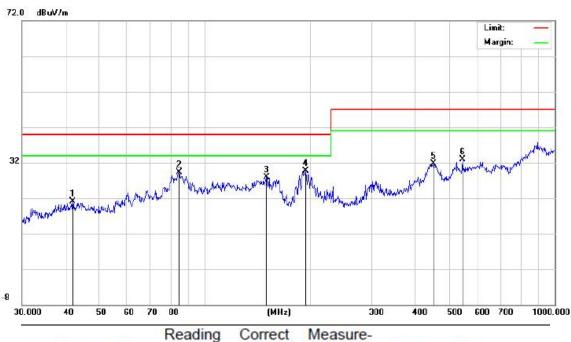


#### 7.4 TEST RESULT

The test modes were carried out for all modes.

The worst test mode of the EUT was Mode 1, and its test data was showed as the follow:

#### RADIATED EMISSION BELOW 1GHZ-HORIZONTAL

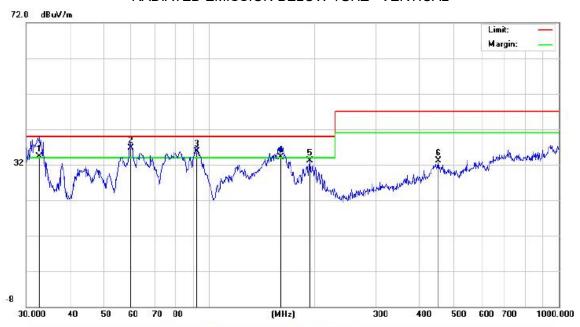


No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		41.8596	7.36	13.77	21.13	40.00	-18.87	peak
2		84.4054	15.59	13.78	29.37	40.00	-10.63	peak
3		150.0108	14.21	13.75	27.96	40.00	-12.04	peak
4	*	194.4534	15.81	13.86	29.67	40.00	-10.33	peak
5		451.1350	6.93	24.71	31.64	47.00	-15.36	peak
6		545.1826	8.98	23.98	32.96	47.00	-14.04	peak

**RESULT: PASS** 



#### RADIATED EMISSION BELOW 1GHZ- VERTICAL



No.	Mk	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1	!	32.7486	19.73	14.51	34.24	40.00	-5.76	QP
2	*	59.8588	19.55	17.10	36.65	40.00	-3.35	QP
3	ļ	92.1388	20.49	15.26	35.75	40.00	-4.25	QP
4	ļ	160.3456	15.91	18.20	34.11	40.00	-5.89	QP
5		194.4534	15.10	18.07	33.17	40.00	-6.83	peak
6		452.7197	7.49	25.53	33.02	47.00	-13.98	peak

**RESULT: PASS** 



Page 18 of 46

#### 8. MAINS TERMINAL DISTURBANCE VOLTAGE MEASUREMENT

#### 8.1. LIMITS OF MAINS TERMINAL DISTURBANCE VOLTAGE

Eroguanov rango (MUz)	Limits (dBuV) Class B ITE				
Frequency range (MHz)	Quasi-peak	Average			
0.15-0.50	66 to 56	56 to 46			
0.50-5	56	46			
5-30	60	50			

**Note:** 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

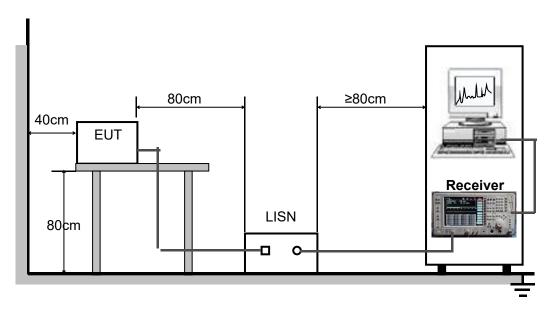
#### **8.2. TEST PROCEDURE**

- (1) The EUT was placed 0.4 meters from the conducting wall of shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). The LISN provide  $50\Omega/50\mu H$  of coupling impedance for the measuring instrument.
- (2) Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- (3)The frequency range from 150 kHz to 30 MHz was searched. Emission levels over 20dB under the prescribed limits are not reported.



Page 19 of 46

#### 8.3. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

L1

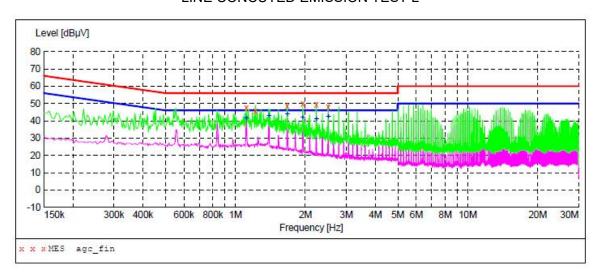


## 8.4. TEST RESULT

The test modes were carried out for all modes.

The worst test mode of the EUT was Mode 2, and its test data was showed as the follow:

#### LINE CONCUTED EMISSION TEST-L



# MEASUREMENT RESULT: "agc fin"

2024/5/20 14	:52					
Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line
1.114000	47.30	6.2	56	8.7	QP	L1
1.218000	45.50	6.2	56	10.5	QP	L1
1.670000	48.40	6.2	56	7.6	QP	L1
1.950000	49.70	6.2	56	6.3	QP	L1
2.230000	49.40	6.3	56	6.6	QP	L1

6.3 56 8.2 QP

#### MEASUREMENT RESULT: "agc fin2"

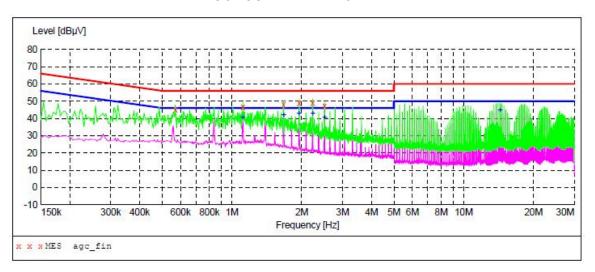
2.510000 47.80

Frequency	Level	Transd	Limit	Margin	Detector	Line
MHz	dΒμV	dB	dΒμV	dB		
1.114000	41.60	6.2	46	4.4	AV	L1
1.394000	42.80	6.2	46	3.2	AV	L1
1.670000	43.60	6.2	46	2.4	AV	L1
1.950000	42.00	6.2	46	4.0	AV	L1
2.230000	40.70	6.3	46	5.3	AV	L1
2.510000	42.30	6.3	46	3.7	AV	L1

#### **RESULT: PASS**



#### LINE CONCUTED EMISSION TEST-N



# MEASUREMENT RESULT: "agc\_fin"

2	024/5/20 14:		Transd	Limit	Margin	Detector	Tipe
	Frequency MHz	dB <sub>µ</sub> V	dB	dBµV	dB	Detector	птие
	0.570000	45.00	6.2	56	11.0	QP	N
	1.114000	46.60	6.2	56	9.4	QP	N
	1.670000	48.10	6.2	56	7.9	QP	N
	1.950000	48.90	6.2	56	7.1	QP	N
	2.230000	48.80	6.3	56	7.2	QP	N
	2.510000	47.20	6.3	56	8.8	QP	N

## MEASUREMENT RESULT: "agc\_fin2"

Frequency				TK-2115	Detector	Line
MHz	dΒμV	dB	dBµV	dB		
1.114000	40.60	6.2	46	5.4	AV	N
1.670000	41.90	6.2	46	4.1	AV	N
1.950000	43.00	6.2	46	3.0	AV	N
2.230000	42.90	6.3	46	3.1	AV	N
2.510000	40.40	6.3	46	5.6	AV	N
14.350000	44.50	6.8	50	5.5	AV	N

#### **RESULT: PASS**



Page 22 of 46

#### 9. HARMONIC CURRENT MEASUREMENT

#### 9.1. LIMITS OF HARMONIC CURRENT

Limits for	Limits for Class A Equipment					
Harmonics Order n	Max. permissible harmonic current (A)					
Od	Odd harmonics					
3	2.30					
5	1.14					
7	0.77					
9	0.40					
11	0.33					
13	0.21					
15≤n≤39	0.15×15/n					
Eve	en harmonics					
2	1.08					
4	0.43					
6	0.30					
8≤n≤40	0.23×8/n					

Note: 1. According to section 5 of EN 61000-3-2: 2014, the EUT is Class A equipment.

2. The above limits are for all applications having an active input power>75W. No limits apply for equipment with an active input power up to and including 75W.

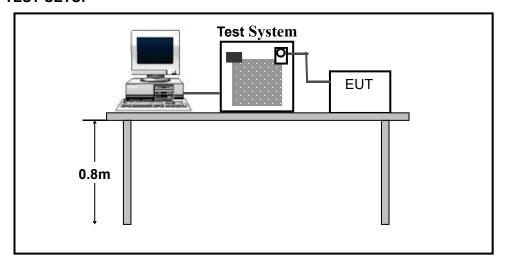
#### 9.2. TEST PROCEDURE

- 1. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- 2. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the necessary for the EUT to be exercised.



Page 23 of 46

#### 9.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.

#### 9.4. TEST RESULT

Equipment with a rated power less than to 75W is deemed to fulfil all relevant requirements of this standard without testing.



Page 24 of 46

#### 10. VOLTAGE FLUCTUATIONS AND FLICK MEASUREMENT

#### 10.1. LIMITS OF VOLTAGE FLUCTUATIONS AND FLICK

Test Item	Limit	Note	
P <sub>st</sub>	1.0	P <sub>st</sub> means Short-term flicker indicator	
P <sub>lt</sub>	0.65	P <sub>lt</sub> means long-term flicker indicator	
T <sub>dt</sub>	0.5	T <sub>dt</sub> means maximum time that d <sub>t</sub> exceeds 3.3%	
d <sub>max</sub> (%)	4%	d <sub>max</sub> means maximum relative voltage change.	
d <sub>c</sub> (%)	3.3%	d₀ means relative steady-state voltage change.	

#### 10.2. TEST PROCEDURE

- 1. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal conditions
- 2. During the flick measurement, the measure time shall include that part of whole operation changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

#### 10.3. TEST SETUP

Same as 9.3

#### 10.4. TEST RESULT

## **Test Specification**

Test Frequency	50Hz	Test Voltage	230V AC
Waveform	Sine	Test Time	10 minutes(P <sub>st</sub> ); 2 hours (P <sub>lt</sub> )

#### **Test Result**

Test Parameter	Measurement Value	Limit	Remarks
P <sub>st</sub>	0.263	1.0	Pass
P <sub>lt</sub>	0.115	0.65	Pass
$T_{dt(s)}$	0.0	0.5	Pass
d <sub>max</sub> (%)	0.00	4%	Pass
d <sub>c</sub> (%)	0.00	3.3%	Pass



Page 25 of 46

#### 11. IMMUNITY TEST

#### 11.1. DESCRIPTION OF PERFORMANCE CRITERIA

The performance criteria are used to take a decision on whether a radio equipment passes or fails immunity tests.

For the purpose of the present document two categories of performance criteria apply:

- Performance criteria for continuous phenomena.
- Performance criteria for transient phenomena.

#### 11.2. GENERAL PERFORMANCE CRITERIA

#### 1. Performance criteria for continuous phenomena

During the test, the equipment shall:

- · continue to operate as intended;
- not unintentionally transmit;
- · not unintentionally change its operating state;
- not unintentionally change critical stored data.

#### 2. Performance criteria for transient phenomena

For all ports and transient phenomena with the exception described below, the following applies:

- The application of the transient phenomena shall not result in a change of the mode of operation (e.g. unintended transmission) or the loss of critical stored data.
- After application of the transient phenomena, the equipment shall operate as intended.

For surges applied to symmetrically operated wired network ports intended to be connected directly to outdoor lines the following criteria applies:

- For products with only one symmetrical port intended for connection to outdoor lines, loss of function is allowed, provided the function is self-recoverable, or can be otherwise restored. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.
- For products with more than one symmetrical port intended for connection to outdoor lines, loss of function on the port under test is allowed, provided the function is self-recoverable. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

For a 0 % residual voltage dip tests the following performance criteria apply:

• The performance criteria for transient phenomena shall apply.

For a 70 % residual voltage dip and voltage interruption tests, the following performance criteria apply:

- in the case where the equipment is fitted with or connected to a battery back-up, the performance criteria for transient phenomena shall apply;
- in the case where the equipment is powered solely from the AC mains supply (without the use of a parallel battery back-up) volatile user data may have been lost and if applicable the communication link need not to be maintained and lost functions should be recoverable by user or operator;
- no unintentional responses shall occur at the end of the test, when the voltage is restored to nominal;
- in the event of loss of function(s) or in the event of loss of user stored data, this fact shall be recorded.



Page 26 of 46

#### 3. Performance Table

EN 301 489-3 Performance criteria					
Criteria During Test After Test					
А	Operate as intended No loss of function No unintentional responses	Operate as intended No loss of function No degradation of performance No loss of stored data or user programmable functions			
В	May show loss of function No unintentional responses	Operate as intended Lost function(s) shall be self-recoverable No degradation of performance No loss of stored data or user programmable functions			

<sup>•</sup> performance criterion A applies for immunity tests with phenomena of a continuous nature;

Where "operate as intended" or "no loss of function" is specified, the EUT shall demonstrate correct functioning as described in EN 301 489-3 clause 5.

Where the EUT has more than one mode of operation, an unplanned transition from one mode to another is considered as an unintentional response. The EUT shall be tested in sufficient modes to confirm there are no such unintentional responses.

<sup>•</sup> performance criterion B applies for immunity tests with phenomena of a transient nature.



Page 27 of 46

#### 12. ELECTROSTATIC DISCHARGE IMMUNITY TEST

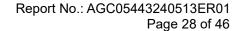
#### 12.1. TEST SPECIFICATION

Basic Standard EN 61000-4-2			
Discharge Impedance 330Ω/150 pF			
Discharge Voltage	Air Discharge:±8kV, Contact Discharge:±4kV		
Polarity	Positive/Negative		
Number of Discharge Minimum 25 times at each test point			
Discharge Mode Single discharge			
Discharge Period 1-second minimum			

#### 12.2. TEST PROCEDURE

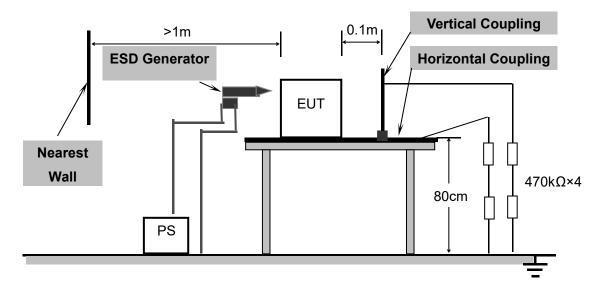
The test procedure was in accordance with EN 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were completed.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned vertically at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m×0.5m) was placed vertically to and 0.1 meters from the EUT.





#### 12.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



Page 29 of 46

#### **ESD** location:

Red line: Contact discharge





Page 30 of 46

#### 12.4. TEST RESULT

Performance criteria for EN 301 489-3 immunity tests

Times of Discharge	Voltage	Coupling	Test Mode	Performance criteria	
Mini 25 / Point	±2kV; ±4kV	Contact discharge	Mode 1/2/3	А	
Mini 25 / Point	±2kV; ±4kV; ±8kV	No Air Discharge	N/A	N/A	
Mini 25 / Point	±4kV	Indirect Discharge HCP	Mode 1/2/3	А	
Mini 25 / Point	±4kV	Indirect Discharge VCP	Mode 1/2/3	А	
A: No degradation in the performance of the EUT was observed.					

#### 12.5. PERFORMANCE

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

⊠ Compliance	☐ Not Compliance	



Page 31 of 46

# 13. RADIATED, RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST

#### 13.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-3
Frequency Range	80MHz-6000MHz
Field Strength	3V/m
Modulation 1 kHz sine wave, 80%, AM modulation	
Frequency Step	1% of fundamental
Polarity of Antenna	Horizontal and Vertical
Test Distance	3m
Antenna Height	1.55m
Dwell Time 3 seconds	

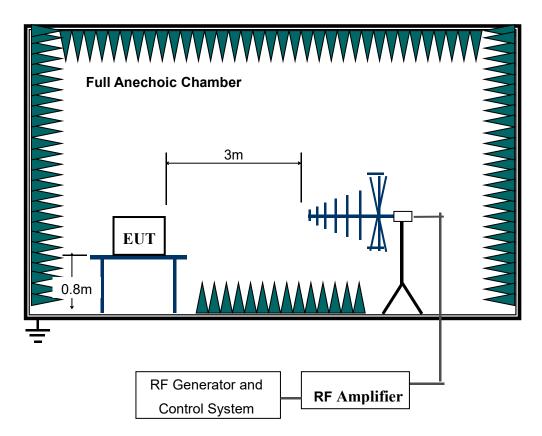
#### 13.2. TEST PROCEDURE

The test procedure was in accordance with EN 61000-4-3.

- a. The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b. The test signal was 80% amplitude modulated with a 1 kHz sine wave.
- c. The frequency range was swept from 80 MHz to 6000MHz with the exception of the exclusion band for transmitters, receivers and duplex transceivers. The rate of sweep did not exceed 1.5×10<sup>-3</sup> decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- d. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- e. The field strength level was 3V/m.
- f. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



#### 13.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



Page 33 of 46

#### 13.4. TEST RESULT

#### Performance criteria for EN 301 489-3 immunity tests

Freq. Range (MHz)	Field	Modulation	Polarity	Position	Test Mode	Performance criteria
80-6000	3V/m	Yes	н	Front	Mode 1/2/3	Α
80-6000	3V/m	Yes	Н	Back	Mode 1/2/3	А
80-6000	3V/m	Yes	Н	Left	Mode 1/2/3	А
80-6000	3V/m	Yes	Н	Right	Mode 1/2/3	А
80-6000	3V/m	Yes	V	Front	Mode 1/2/3	А
80-6000	3V/m	Yes	V	Back	Mode 1/2/3	А
80-6000	3V/m	Yes	V	Left	Mode 1/2/3	А
80-6000	3V/m	Yes	V	Right	Mode 1/2/3	А

A: No degradation or PER < 10% in the performance of the EUT was observed.

#### 13.5. PERFORMANCE

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
	☐ Not Compliance



Page 34 of 46

#### 14. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

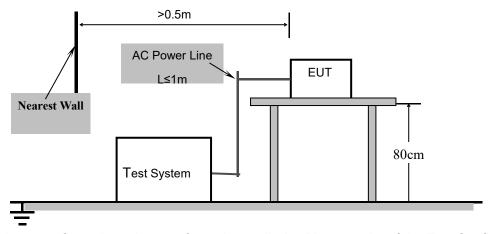
#### 14.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-4
Test Voltage	a.c. power port–1kV
Polarity	Positive/Negative
Impulse Frequency	5kHz
Impulse wave shape	5/50ns
<b>Burst Duration</b>	15ms
Burst Period	300ms
Test Duration Not less than 1min.	

#### 14.2. TEST PROCEDURE

- 1. The EUT was tested with 1000 volt discharges to the AC power input leads.
- 2. Both positive and negative polarity discharges were applied.
- 3. The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 1 meter.
- 4. The duration time of each test sequential was 1 minute.
- 5. The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.

#### 14.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



Page 35 of 46

#### 14.4. TEST RESULT

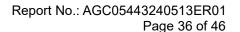
Polarity	Test Level (kV)	Test Mode	Performance criteria
+/-	1	Mode 1/2/3	A
+/-	1	Mode 1/2/3	А
+/-	1	Mode 1/2/3	Α
+/-	1	Mode 1/2/3	А
	+/- +/- +/-	+/- 1 +/- 1 +/- 1	+/- 1 Mode 1/2/3 +/- 1 Mode 1/2/3 +/- 1 Mode 1/2/3

A: No degradation in the performance of the EUT was observed.

#### 14.5. PERFORMANCE

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

⊠ Compliance	■ Not Compliance		





#### 15. SURGE IMMUNITY TEST

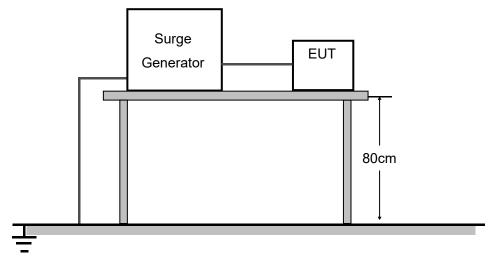
#### 15.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-5	
Waveform Voltage 1.2/50μs; Current 8/20μs		
Test Voltage	a.c. power port, line to line 1.0kV	
Polarity Positive/Negative		
Phase Angle	0°, 90°, 180°, 270°	
Repetition Rate	60sec	
Times 5 time/each condition.		

#### 15.2. TEST PROCEDURE

- a. The EUT and the auxiliary equipment were placed on a table of 0.8m heights above a metal ground reference plane. The size of ground plane is greater than 1m×1m and project beyond the EUT by at least 0.1m on all sides. The ground plane is connected to the protective earth. The length of power cord between the coupling device and the EUT was less than 2 meters (provided by the manufacturer).
- b. The EUT was connected to the power mains through a coupling device that directly couples the surge interference signal. The surge noise was applied synchronized to the voltage phase at the zero crossing and the peak value of the AC voltage wave (positive and negative).
- c. The surges were applied line to line and line(s) to earth. All lower levels including the selected test level were tested. The polarity of each surge level included positive and negative test pulses.

## 15.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



Page 37 of 46

#### 15.4. TEST RESULT

Coupling Line	Polarity	Voltage (kV)	Test Mode	Performance criteria
a.c. power, L-N	+/-	1.0	Mode 1/2/3	А
A. N. da and dation in the conformation of the CUT was already				

A: No degradation in the performance of the EUT was observed.

#### 15.5. PERFORMANCE

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

$\boxtimes$	Compliance	☐ Not Compliance	



## 16. IMMUNITY TO CONDUCTED DISTURBANCES INDUCED BY RF FIELDS

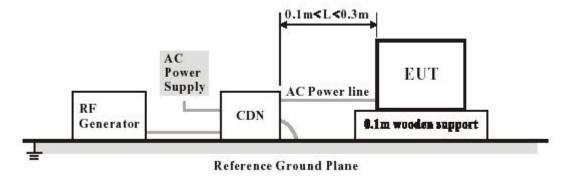
#### 16.1. TEST SPECIFICATION

Basic Standard EN 61000-4-6		
Daoio Gtaridara	LIV 01000 4 0	
Frequency Range	0.15MHz-80MHz	
Field Strength	3Vrms	
Modulation	Modulation 1 kHz Sine Wave, 80% AM	
Frequency Step 1% of fundamental		
Coupled Cable a.c. power line		
Coupling Device CDN		

#### **16.2. TEST PROCEDURE**

- 1. The EUT shall be tested within its intended operating and climatic conditions.
- The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.
- 3. The test signal was 80% amplitude modulated with a 1 kHz sine wave
- 4. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80% amplitude. The sweep rate shall not exceed 1.5×10-3 decades/s. The step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value where the frequency is swept incrementally.
- 5. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies such as clock frequencies and harmonics or frequencies of dominant interest, shall be analyzed separately.
- 6. Attempts should be made to fully exercise the EUT during test, and to fully interrogate all exercise modes selected for susceptibility.

#### 16.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



Page 39 of 46

#### 16.4. TEST RESULT

Test Point	Frequency (MHz)	Level (V rms)	Test Mode	Performance criteria
a.c. port	0.15 – 80	3	Mode 1/2/3	Α
A: No degradation in the performance of the FLIT was observed				

A: No degradation in the performance of the EUT was observed.

#### **16.5. PERFORMANCE**

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
	e 🗌 Not Compliance

D	Compliance	☐ Not Compliance		



Page 40 of 46

#### 17. VOLTAGE DIPS AND SHORT INTERRUPTIONS IMMUNITY TEST

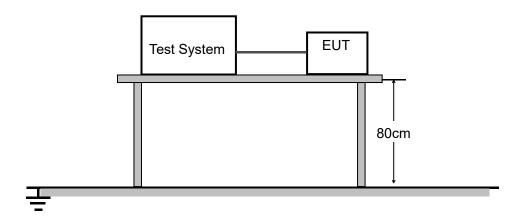
#### 17.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-11		
	100% reduction, 0.5 Cycle		
Voltage Dips	100% reduction, 1.0 Cycle		
	30% reduction, 25 Cycles		
Voltage Interruptions	100% reduction, 250 Cycles		
Voltage Phase Angle	0°, 45°, 90°, 135°, 180°, 225°, 270°, 315°		

#### 17.2. TEST PROCEDURE

- a). The power cord was used as supplied by the manufacturer. The EUT was connected to the line output of the Voltage Dips and Interruption Generator.
- b). The EUT was tested for (1) 100% voltage dip of supplied voltage with duration of 0.5 cycles, (2)100% voltage dip of supplied voltage and duration 1.0 cycle. (3) 30% voltage dip of supplied voltage and duration 25 cycles. (4) 100% voltage interruption of supplied voltage with duration of 250 Cycles was followed.
- c). Voltage reductions occur at 0 degree crossover point of the voltage waveform. The performance of the EUT was checked after the voltage dip or interruption.

#### 17.3. TEST SETUP



For the actual test configuration, please refer to Appendix A, Photographs of the Test Configuration.



Page 41 of 46

#### 17.4. TEST RESULT

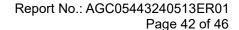
Test Mode	Voltage Reduction	Duration (cycle)	Times	Interval (Sec)	Test Mode	Performance criteria
	100%	0.5	3	10	Mode 1/2/3	А
Voltage dips	100%	1	3	10	Mode 1/2/3	А
	30%	25	3	10	Mode 1/2/3	А
Voltage interruptions	100%	250	3	10	Mode 1/2/3	В

- A: No degradation in the performance of the EUT was observed.
- B: Stop charging during the test and self-recoverable after test.
- C: Lost functions can be recoverable by user or operator.

#### 17.5. PERFORMANCE

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
⊠ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

	☐ Not Compliance			
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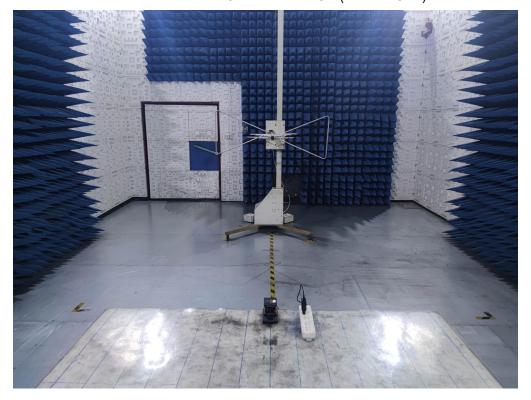


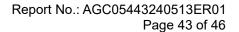
## **APPENDIX A: PHOTOGRAPHS OF TEST SETUP**

LINE CONDUCTED EMISSION TEST SETUP



RADIATED EMISSION TEST SETUP (Below 1GHz)



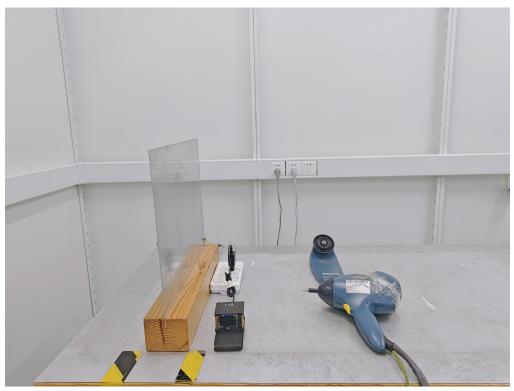


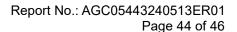


#### EN61000-3-3 VOLTAGE FLUCTUATION ANDFLICKER TEST SETUP



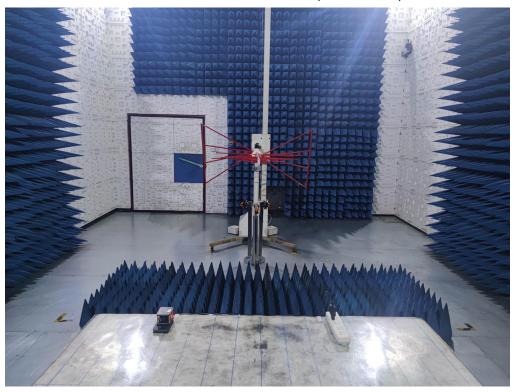
EN 61000-4-2 ESD TEST SETUP





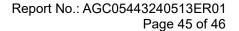


# EN 61000-4-3 RS TEST SETUP (Below 1GHz)



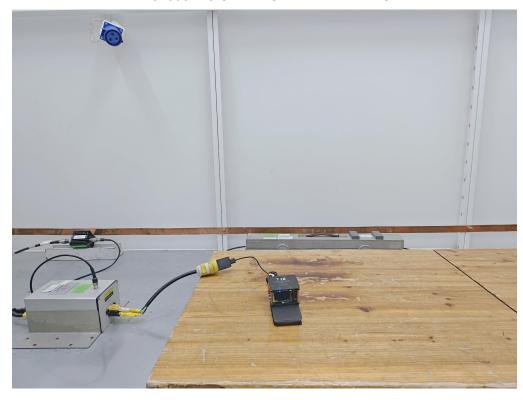
EN 61000-4-4/-5/-11EFT/SURGE/DIPS IMMUNITY TEST SETUP







#### EN 61000-4-6 CS IMMUNITY TEST SETUP





Page 46 of 46

#### APPENDIX B: PHOTOGRAPHS OF THE EUT

Refer to the Report No.: AGC05443240513AP01

----END OF REPORT----



# Conditions of Issuance of Test Reports

- 1. All samples and goods are accepted by the Attestation of Global Compliance (Shenzhen) Co., Ltd (the "Company") solely for testing and reporting in accordance with the following terms and conditions. The company provides its services on the basis that such terms and conditions constitute express agreement between the company and any person, firm or company requesting its services (the "Clients").
- 2. Any report issued by Company as a result of this application for testing services (the "Report") shall be issued in confidence to the Clients and the Report will be strictly treated as such by the Company. It may not be reproduced either in its entirety or in part and it may not be used for advertising or other unauthorized purposes without the written consent of the Company. The Clients to whom the Report is issued may, however, show or send it, or a certified copy thereof prepared by the Company to its customer, supplier or other persons directly concerned. The Company will not, without the consent of the Clients, enter into any discussion or correspondence with any third party concerning the contents of the Report, unless required by the relevant governmental authorities, laws or court orders.
- 3. The Company shall not be called or be liable to be called to give evidence or testimony on the Report in a court of law without its prior written consent, unless required by the relevant governmental authorities, laws or court orders.
- 4. In the event of the improper use of the report as determined by the Company, the Company reserves the right to withdraw it, and to adopt any other additional remedies which may be appropriate.
- 5. Samples submitted for testing are accepted on the understanding that the Report issued cannot form the basis of, or be the instrument for, any legal action against the Company.
- 6. The Company will not be liable for or accept responsibility for any loss or damage however arising from the use of information contained in any of its Reports or in any communication whatsoever about its said tests or investigations.
- 7.Clients wishing to use the Report in court proceedings or arbitration shall inform the Company to that effect prior to submitting the sample for testing.
- 8. The Company is not responsible for recalling the electronic version of the original report when any revision is made to them. The Client assumes the responsibility to providing the revised version to any interested party who uses them.
- 9. Subject to the variable length of retention time for test data and report stored hereinto as otherwise specifically required by individual accreditation authorities, the Company will only keep the supporting test data and information of the test report for a period of six years. The data and information will be disposed of after the aforementioned retention period has elapsed. Under no circumstances shall we provide any data and information which has been disposed of after retention period. Under no circumstances shall we be liable for damage of any kind, including (but not limited to) compensatory damages, lost profits, lost data, or any form of special, incidental, indirect, consequential or punitive damages of any kind, whether based on breach of contract of warranty, tort (including negligence), product liability or otherwise, even if we are informed in advance of the possibility of such damages.